

SEARCHED			
Class	Sub.	Date	Exmr.
382	199 286 274	7-19-04	GmL
348	353	7-20-04	GmL
345	617	7-20-04	GmL

INTERFERENCE SEARCHED			
Class	Sub.	Date	Exmr.

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	Date	Exmr.
inventor search	7-13-04	cmh
SPIE, IEEE, ACM Searched: "contrast + image + measuring/calculating/ computing/etc."	7-19-04	cmh
EAST search attached	7-26-04	cmh
Best Available Co		

**Best Available Copy**

(RIGHT OUTSIDE)